Notice of References Cited Application/Control No. 10/789,319 Examiner Marc S. Zimmer Applicant(s)/Patent Under Reexamination XU ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
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	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N.	EP 803 555 A2	04-1997	Europe	Kawazu et al.	
	0/	JP 2-219881 A	09-1990	Japan	Tanaka et al.	
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NON-PATENT DOCUMENTS

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